

# NASA Electronic Parts and Packaging

## NEPP Program Task 14-294: Joint Hermeticity Correlation Study

NASA MSFC/GSFC

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## I. Hermeticity 101

## II. Task Objectives

## III. Task Update

A. Instrument Correlation Study

B. Gross Leak Standard Development

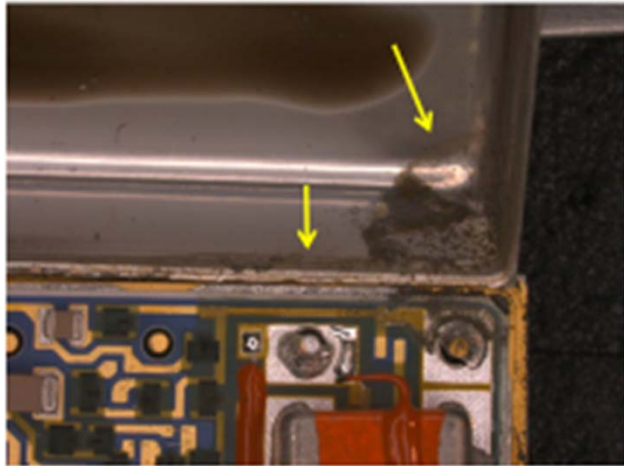
C. Test Method Optimization

High reliability design applications typically require the use of hermetically sealed microelectronics to insure device longevity and ruggedness in an attempt to mitigate risk to mission critical electronic systems.

- Damaged or defective seals and feedthroughs can allow ambient air/water vapor to enter the internal cavity of a device which over time and under the right conditions can lead to device failure.
- Examples of failure modes due to moisture/air ingress:
  - Chemical corrosion of device metallization
  - Die lifts due to oxidation of solder die attach
  - Surface electrical leakage
  - Electrical shorts due to dendritic growth
  - Stiction in MEMS
  - Arc discharge in the presence of Argon

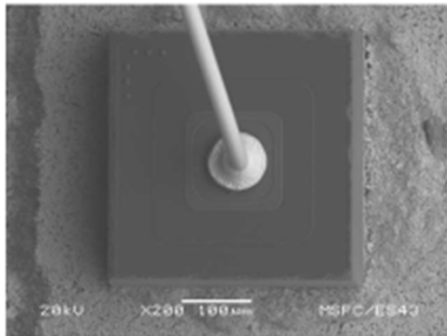
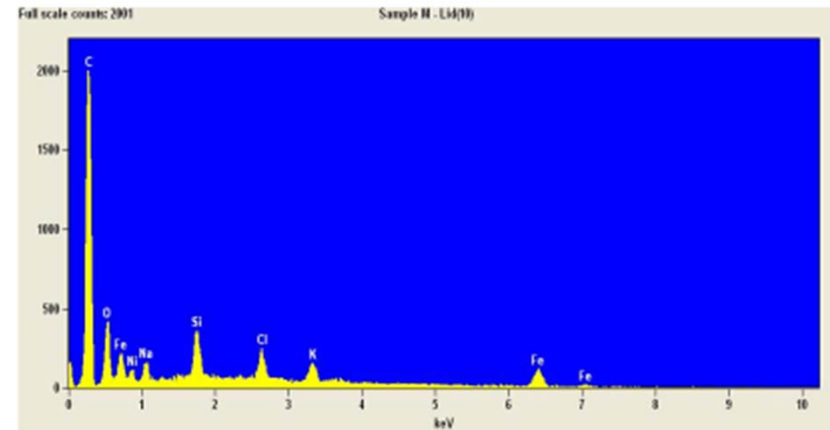
- **Hermetic Failures**

*Evidence of corrosion with reduced electrical stability*

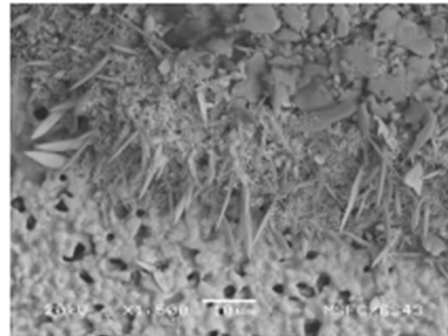


Examination of a representative  $Ag_2S$  corrosion area

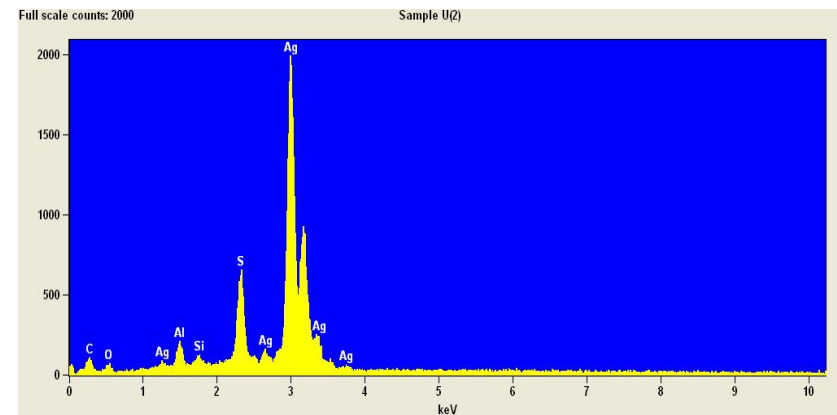
Elemental analysis provides evidence of ionic contamination and corrosion



Die and bond area at low magnification



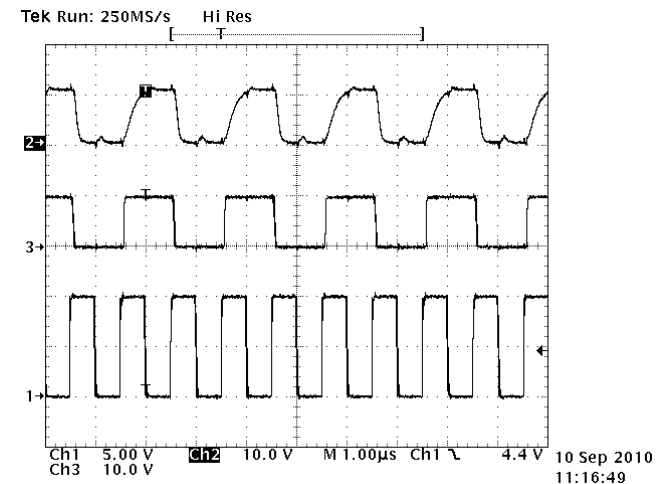
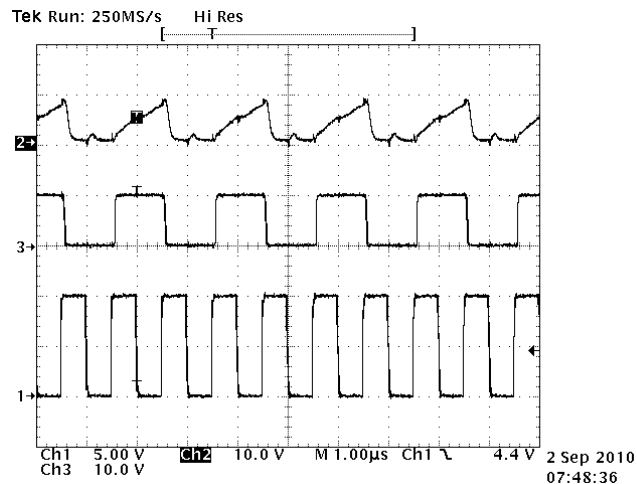
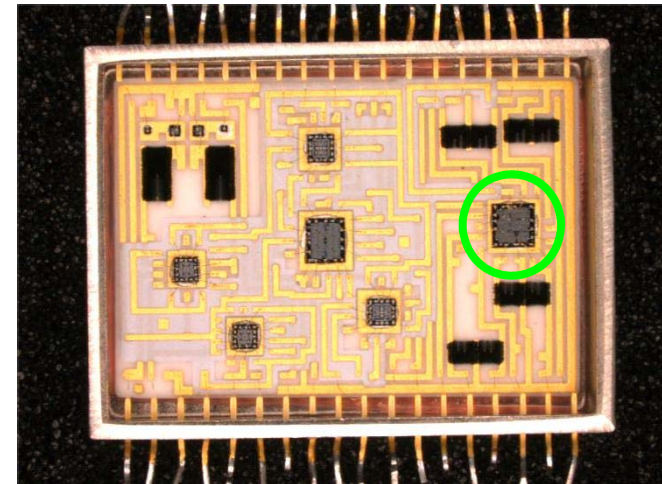
Evidence of heavy growth of  $Ag_2S$  along Ag die attach edge and bond pad



- **Surface Electrical Leakage**

*Electrical instability in the presence of ionic contamination and moisture*

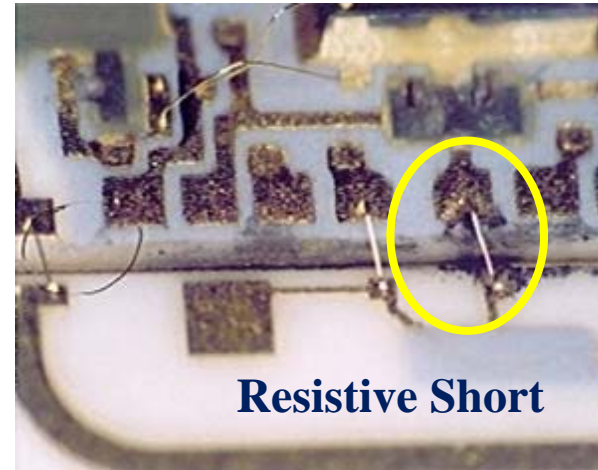
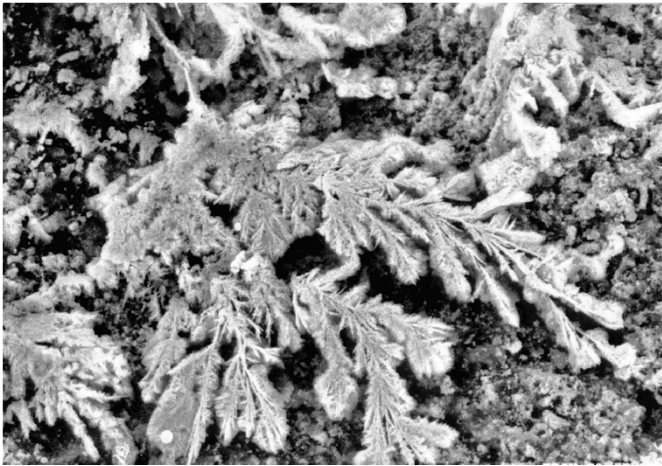
- Failure: MDM Module in an IEA (2009)
- Isolated: 8-bit CMOS Shift Reg. Die (LDC 8222)
- Electrical Testing
  - As Received
  - 24 hr Bake Out @ 125°C





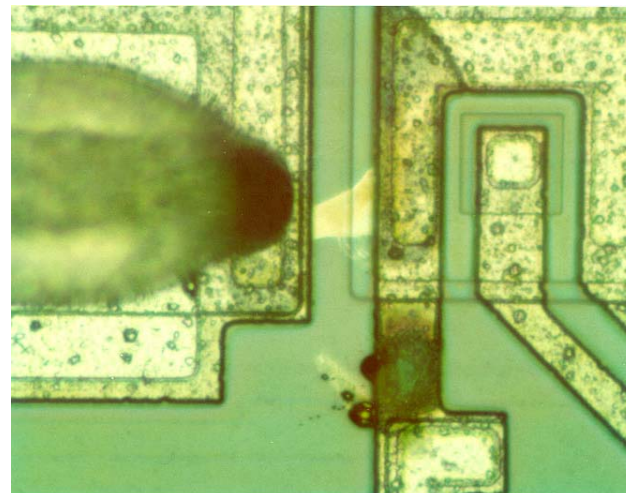
- **Dendritic Growth**

*Growth is caused by a combination of electrical bias, contamination, and moisture*



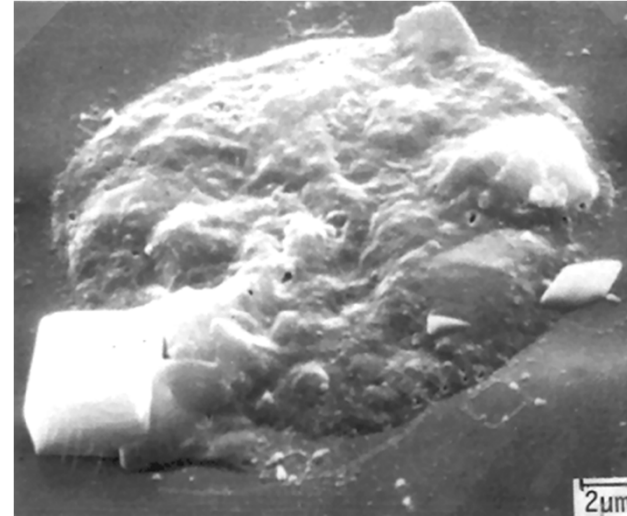
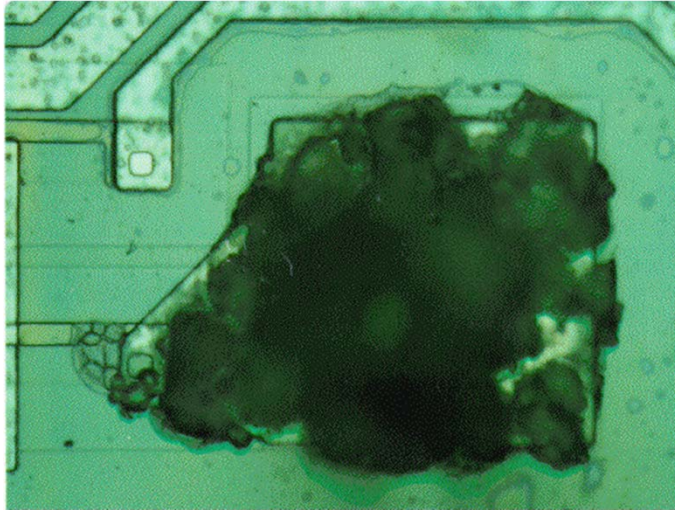
- **Surface Arcs**

*Usually occur over a 300V transient but are dependent on surface glassivation and moisture*



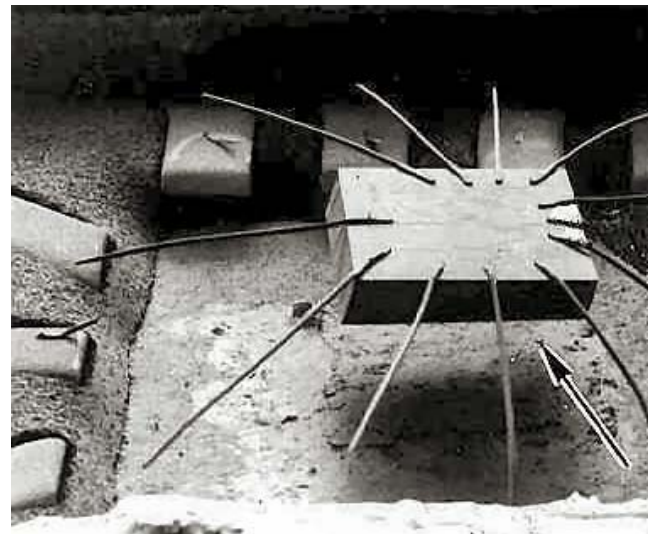
- **Corrosion**

*Aluminum bond pad corrosion in the presence of ionic contamination and moisture*

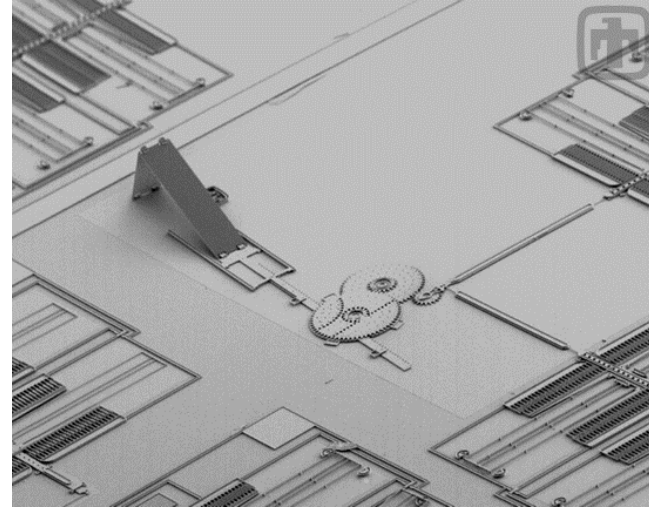
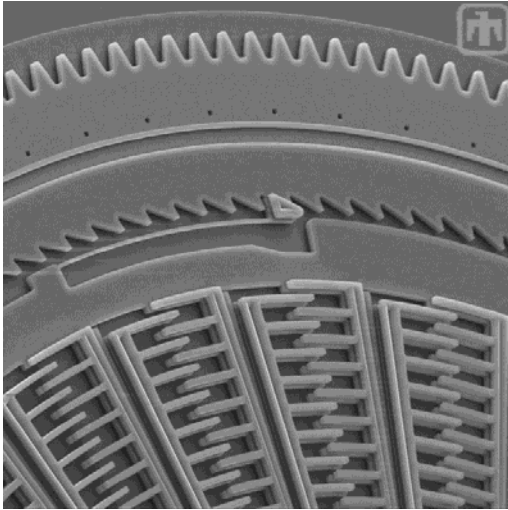


- **Die Lifting**

*Oxidation of Solder Die Attach*



- **MEMS Failure Modes**



***Stiction:***

*Internal MEMS structures are so small that surface forces (capillary condensation, van der Waals molecular forces, and chemical and hydrogen bonds between the surfaces) cause microscopic structures to stick together when their surfaces come into contact.*

***Humidity:***

*Surface micromachined devices are extremely hydrophilic for reasons related to processing. In the presence of humidity, water will condense into small cracks and pores on the surface of these structures (i.e. gears) and effect operability.*



Fine and gross leak testing are used to determine the effectiveness of package seals in microelectronic packages.

- Most specifications for hermeticity testing define leak rates larger than  $10^{-5}$  as being GROSS and smaller than  $10^{-6}$  as being FINE.
- Three systems are used to non-destructively test: CHLD, KR-85, OLT
  - *CHLD, Kr-85 systems use back pressurization of a tracer gas to enter existing leak paths. A detector is used to determine the presence of gas.*
  - *OLT uses an interferometer to measure package lid deflection in the response to changes in ambient pressure. The amount or absence of lid deflection is directly correlated to a helium leak rate.*
- Testing is performed in accordance with MIL-STD-883, Test Method 1014 for hybrids/microcircuits and MIL-STD-750 for 1071 for discrete semiconductor devices

## **NEPP Hermeticity task is a collaborative effort between GSFC/MSFC to address the following:**

- Determine CHLD test equipment capability between NASA centers as well as correlation of test results with other equipment used for hermeticity testing (OLT, Krypton-85, IGA)
- Design, fabricate, and test gross leak hermeticity standards
- Provide input to DLA Land & Maritime to optimize hermeticity specifications based on the knowledge gained during correlation studies, part testing, and research efforts

## What was the purpose of this study?

*Conduct a round robin study of non-hermetic parts to evaluate hermetic test equipments capability to positively identify fine and gross leaking devices.*



**CHLD**  
(Pernicka 700H System)



**Krypton-85**  
(IsoVac Mark V Bomb Station)



**OLT System**  
(NorCom 2020 Optical Leak Test System)

## Step 1 Secure Non-Hermetic Parts

- Obtained 3 sets 10 parts each of MIL-STD-750 gross/fine leakers from IsoVac, Inc. which were go/no go tested (Prerequisites: Nitrogen sealed, no fluorocarbon/red dye testing)
- 3 package styles were used: TO-18, TO-5, and UB

## Step 2 Confirm GSFC/MSFC CHLD Performance

- Used 2 calibrated helium leak standards to verify high/low leak range accuracy
- Verified empty chamber values to confirm analyzer sensitivity to detect fine leaks and set GLT to detect gross leaks

## Step 3 Test Parts Using CHLD, OLT, and Kr85 Equipment

- Order of testing was CHLD-MSFC, CHLD-GSFC, OLT - NorCom, Kr85-IsoVac, Kr85-MSFC, Kr85 Red Dye-IsoVac (if applicable)
- Exception: Set 1 T0-18 gross leakers were tested by CHLD-MSFC after OLT-NorCom

## Step 4: Test Parts With IGA to Confirm Parts Selected Were Non-Hermetic

- Testing was done for final confirmation of part hermeticity and to ensure fluorocarbons were not present which could skew test results



## CHLD

- MSFC/GSFC tested in accordance with MIL-STD-750 TM1071 Test Condition CH<sub>2</sub>
- Both used identical bombing conditions, equipment setup, and comparable wait times prior to testing each sample
- CHLD test conditions and system setup are summarized in a backup chart

## OLT

- NorCom, Inc. tested in accordance with MIL-STD-750 TM1071 Test Condition L<sub>2</sub>
- OLT test and bombing conditions were determined by NorCom
- Testing was observed by GSFC
- OLT test conditions and system setup are summarized in a backup chart







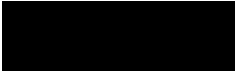

## Kr85

- MSFC/IsoVac Eng., Inc. tested in accordance with MIL-STD-750 TM1071
- Gross leak was performed using Test Condition B
- Fine leak was performed using Test Condition G-1
- Red dye testing was performed by IsoVac Eng., Inc. in accordance with Test Condition A
- Test conditions and system setup are summarized in a backup chart.

## IGA

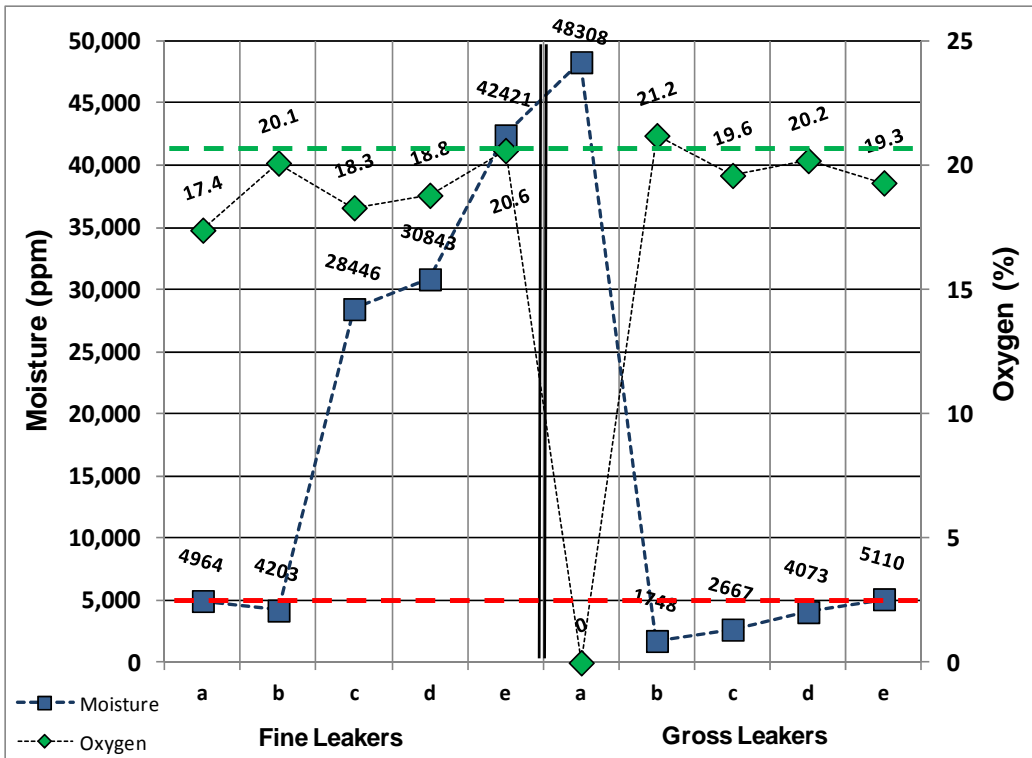
- ORS, Inc. tested in accordance with MIL-STD-750 TM1018
- TO-5, TO-18 IGA was performed using a quadrupole mass spectrometer. TO-18 required special mounting (<0.7cm diameter)
- UB High Resolution HR-IGA was performed using a time of flight (TOF) mass spectrometer. (volume <0.01)
- All samples were prebaked 16-24hrs @100°C and tested at 100°C

## Legend for Correlation Data Tables

|   |  |
|---|--|
|    | Failed (correlates with baseline Kr85 and RGA)             |
|    | Failed fine when initially Kr85 failed as gross            |
|    | Failed gross when initially Kr85 failed as fine            |
|    | Plugged resulting in passing a failed part                 |
|   | OLT passed device when other instruments failed the device |
|  | OLT fails device when CHLD/Kr85 data indicates its plugged |
|  | Instrument not capable to test part                        |
|  | Not Applicable   |

| System | Order of Testing   | Fine                                   |   |   |   |   | Results | Gross |   |   |   |   | Results |
|--------|--------------------|--|---|---|---|---|---------|-------|---|---|---|---|---------|
|        |                    | a                                      | b | c | d | e |         | a     | b | c | d | e |         |
| Kr85   | IsoVac (Pass/Fail) |  |   |   |   |   | 5/5     |       |   |   |   |   | 5/5     |
| CHLD   | MSFC               | P                                      | P | P | P | P | 0/5     |       |   |   |   |   | 5/5     |
|        | GSFC               | P                                      | P | P | P | P | 0/5     |       |   |   |   |   | 5/5     |
| OLT    | Norcom             | Package Type Cannot Be Tested With OLT |   |   |   |   |         |       |   |   |   |   |         |
| Kr85   | IsoVac             | P                                      | P | P | P | P | 0/5     |       |   |   |   |   | 5/5     |
|        | MSFC               | P                                      | P | P | P | P | 0/5     |       |   |   |   |   | 5/5     |
|        | IsoVac (Red Dye)   | P                                      | P | P | P | P | 0/5     | N/A   |   |   |   |   |         |
| RGA    | ORS                |  |   |   |   |   | 5/5     |       |   |   |   |   | 5/5     |

Lot Date Code is unknown; Fine leak limit is  $1 \times 10^{-9}$  atm-cc/sec air



## Test Result Summary

### Gross:

- All instruments but OLT identified gross leakers per Mil-STD-750 TM's
- 5/10 RGA moisture under ppm failure criteria but indicated atmospheric exchange (Note: 883 would have passed these 4)
- 100% correlation between Kr85, CHLD, IGA.

### Fine:

- Parts are plugged. Initially Kr85 was able to detect leakers subsequent CHLD, OLT, Kr85 testing could not.

## Handling & Testing

- When non-hermetic parts are handled/tested outside of a clean room environment atmospheric particle counts are higher and can plug existing leak paths.
- Test conditions during screening by mfg/user can expose device to ambient conditions and thermal/pressurized environments which can result in conditions conducive to plugging.

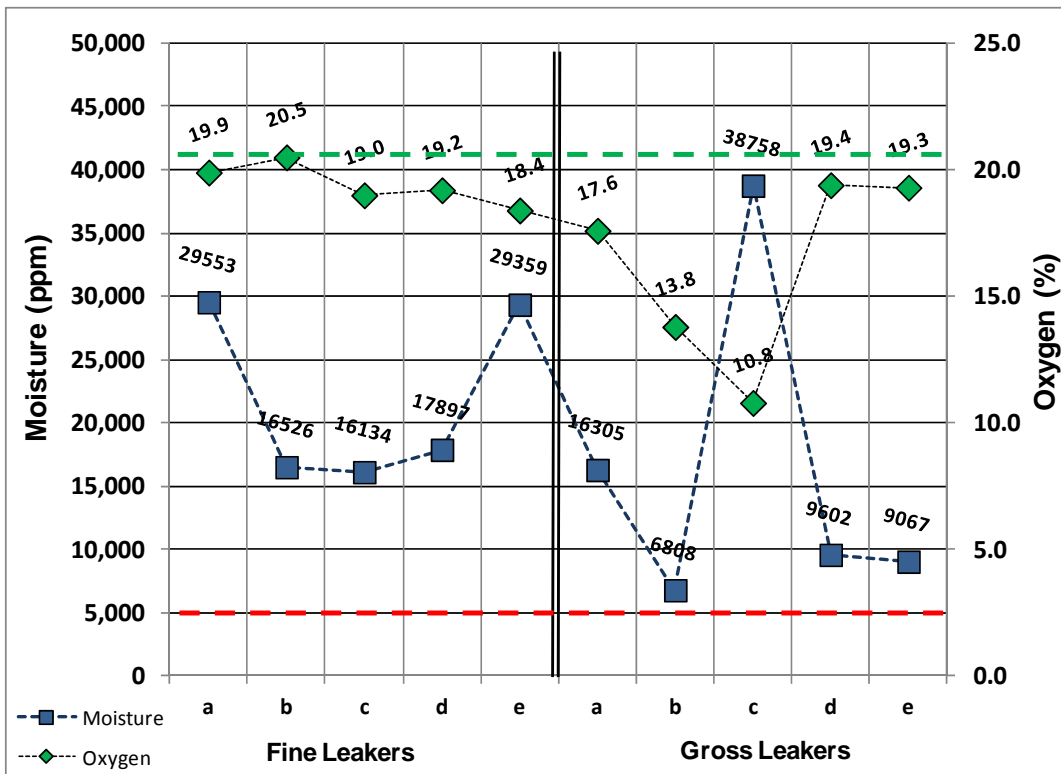
## Storage

- Parts stored in ambient conditions provides a suitable environment for oxidation. Metal compounds used in the sealing process and device construction can rust and plug existing leak paths.
- Storage conditions that allow moisture ingress or internal moisture to form inside the device cavity can cause one way leakers.



| Order of Testing   | Fine    |         |         |         |         | Results | Gross   |         |   |         |         | Results |
|--------------------|---------|---------|---------|---------|---------|---------|---------|---------|---|---------|---------|---------|
|                    | a       | b       | c       | d       | e       |         | a       | b       | c | d       | e       |         |
| IsoVac (Pass/Fail) |         |         |         |         |         | 5/5     |         |         |   |         |         | 5/5     |
| MSFC               | 2.5E-08 | G       | G       | G       | 1.6E-08 | 5/5     |         |         |   | 1.2E-08 | 1.2E-08 | 5/5     |
| GSFC               | 2.5E-08 | G       | 3.4E-08 | 2.5E-08 | 1.8E-08 | 5/5     | 3.7E-08 | 3.8E-08 |   | 1.5E-08 | 1.6E-08 | 5/5     |
| Norcom             | P       | 2.9E-08 | P       | 8.3E-09 | P       | 2/5     | P       | P       |   | P       | P       | 1/5     |
| MSFC               | P       | 1.6E-08 | P       | 4.1E-08 | P       | 2/5     | 1.7E-08 | P       |   | P       | P       | 2/5     |
| IsoVac (Final)     | P       | 2.4E-08 | P       | 3.9E-08 | P       | 2/5     | 1.7E-08 | P       |   | P       | P       | 2/5     |
| ORS                |         |         |         |         |         | 5/5     |         |         |   |         |         | 5/5     |

Lot Date Code 1009; Fine leak limit is  $5 \times 10^{-9}$  atm-cc/sec air



## Test Result Summary

### Gross:

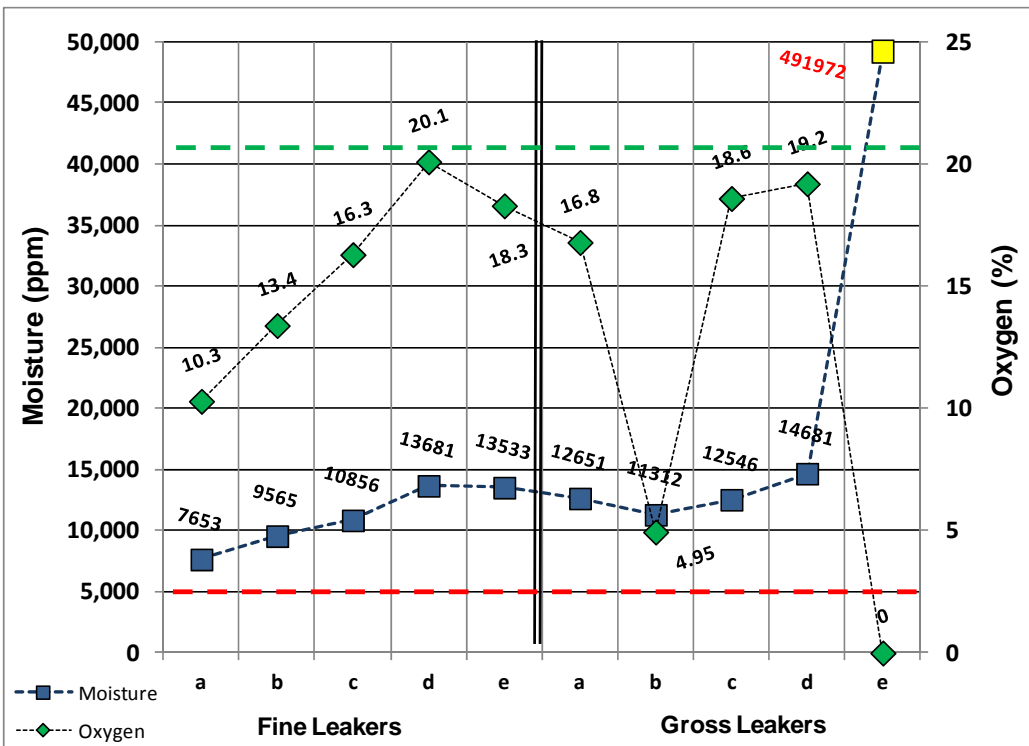
- MSFC/GSFC CHLD failed all 5 parts
- 3 parts plugged after CHLD testing
- Of 2 remaining parts, OLT passed 1 failed part and failed 1 part.
- Kr85 failed 2 parts which correlates with CHLD and conflicts with OLT
- RGA data confirms that all 5 parts were leakers

### Fine:

- CHLD failed all 5 parts
- 3 parts plugged after CHLD GSFC testing allowing Kr85 to only fail 2 parts
- RGA data confirms that all 5 parts were leakers

| System   | Order of Testing   | Fine |         |         |   |   | Results | Order of Testing   | Gross |   |         |         |   | Results |
|----------|--------------------|------|---------|---------|---|---|---------|--------------------|-------|---|---------|---------|---|---------|
|          |                    | a    | b       | c       | d | e |         |                    | a     | b | c       | d       | e |         |
| Kr85     | IsoVac (Pass/Fail) |      |         |         |   |   | 5/5     | IsoVac (Pass/Fail) |       |   |         |         |   | 5/5     |
| CHLD/OLT | CHLD:MSFC          | P    | P       | G       | P | G | 2/5     | CHLD: GSFC         | P     |   | P       |         | P | 2/5     |
|          | CHLD: GSFC         | P    | P       | P       | P | P | 0/5     | OLT: Norcom        |       |   | 9.2E-08 | 1.3E-08 | P | 3/5     |
|          | OLT: Norcom        | G    | 1.2E-08 | 1.9E-08 | P | G | 4/5     | CHLD: MSFC         | P     |   | P       | P       | P | 1/5     |
| Kr85     | IsoVac             | P    | P       | P       | P | P | 0/5     | IsoVac             | P     | P | P       | P       | P | 0/5     |
|          | MSFC               | P    | P       | P       | P | P | 0/5     | MSFC               | P     | P | P       | P       | P | 0/5     |
|          | IsoVac (Red Dye)   | P    | P       | P       | P | P | 0/5     | IsoVac (Red Dye)   | N/A   | P | N/A     | N/A     | P | 0/2     |
| RGA      | ORS                |      |         |         |   |   | 5/5     | ORS                |       |   |         |         |   | 5/5     |

Lot Date Code is 0937; Fine leak limit is  $5 \times 10^{-9}$  atm-cc/sec air



## Test Result Summary

### Gross:

- All samples exhibited plugging
- CHLD GSFC passed one failed part that NorCom identified as a fine leak.
- One part shifted during OLT testing and would require retesting ( ?? Wait time and 5 hr rebomb)

### Fine:

- All samples exhibited plugging
- GSFC identified all parts as passed. MSFC indicated 2 parts failed. OLT indicated 4 parts failed. Several scenarios unable to make a conclusion due to lack of correlation.

# Correlation Without OLT



| Part                          | System | Order of Testing   | Fine |   |   |   |   | Results | Order of Testing   | Gross |   |     |     |   | Results |
|-------------------------------|--------|--------------------|------|---|---|---|---|---------|--------------------|-------|---|-----|-----|---|---------|
|                               |        |                    | a    | b | c | d | e |         |                    | a     | b | c   | d   | e |         |
| Set 1<br>(TO-18)<br>0.0345 cc | Kr85   | IsoVac (Pass/Fail) |      |   |   |   |   | 5/5     | IsoVac (Pass/Fail) |       |   |     |     |   | 5/5     |
|                               | CHLD   | CHLD:MSFC          | P    | P | G | P | G | 2/5     | CHLD: GSFC         | P     |   | P   |     | P | 2/5     |
|                               |        | CHLD: GSFC         | P    | P | P | P | P | 0/5     | CHLD: MSFC         | P     |   | P   | P   | P | 1/5     |
|                               | Kr85   | IsoVac             | P    | P | P | P | P | 0/5     | IsoVac             | P     | P | P   | P   | P | 0/5     |
|                               |        | MSFC               | P    | P | P | P | P | 0/5     | MSFC               | P     | P | P   | P   | P | 0/5     |
|                               |        | IsoVac (Red Dye)   | P    | P | P | P | P | 0/5     | IsoVac (Red Dye)   | N/A   | P | N/A | N/A | P | 0/2     |
|                               | RGA    | ORS                |      |   |   |   |   | 5/5     | ORS                |       |   |     |     |   | 5/5     |

| Part                         | System | Order of Testing   | Fine    |         |         |         |         | Results | Gross   |         |   |         |         | Results |
|------------------------------|--------|--------------------|---------|---------|---------|---------|---------|---------|---------|---------|---|---------|---------|---------|
|                              |        |                    | a       | b       | c       | d       | e       |         | a       | b       | c | d       | e       |         |
| Set 2<br>(TO-5)<br>0.2244 cc | Kr85   | IsoVac (Pass/Fail) |         |         |         |         |         | 5/5     |         |         |   |         |         | 5/5     |
|                              | CHLD   | MSFC               | 2.5E-08 | G       | G       | G       | 1.6E-08 | 5/5     |         |         |   | 1.2E-08 | 1.2E-08 | 5/5     |
|                              |        | GSFC               | 2.5E-08 | G       | 3.4E-08 | 2.5E-08 | 1.8E-08 | 5/5     | 3.7E-08 | 3.8E-08 |   | 1.5E-08 | 1.6E-08 | 5/5     |
|                              | Kr85   | MSFC               | P       | 1.6E-08 | P       | 4.1E-08 | P       | 2/5     | 1.7E-08 | P       |   | P       | P       | 2/5     |
|                              |        | IsoVac (Final)     | P       | 2.4E-08 | P       | 3.9E-08 | P       | 2/5     | 1.7E-08 | P       |   | P       | P       | 2/5     |
| RGA                          | ORS    |                    |         |         |         |         | 5/5     |         |         |         |   |         | 5/5     |         |

| Part                            | System | Order of Testing   | Fine |   |   |   |     | Results | Gross |   |   |   |     | Results |
|---------------------------------|--------|--------------------|------|---|---|---|-----|---------|-------|---|---|---|-----|---------|
|                                 |        |                    | a    | b | c | d | e   |         | a     | b | c | d | e   |         |
| Set 3<br>(ceramic)<br>0.0026 cc | Kr85   | IsoVac (Pass/Fail) |      |   |   |   |     | 5/5     |       |   |   |   |     | 5/5     |
|                                 | CHLD   | MSFC               | P    | P | P | P | P   | 0/5     |       |   |   |   |     | 5/5     |
|                                 |        | GSFC               | P    | P | P | P | P   | 0/5     |       |   |   |   |     | 5/5     |
|                                 | Kr85   | IsoVac             | P    | P | P | P | P   | 0/5     |       |   |   |   |     | 5/5     |
|                                 |        | MSFC               | P    | P | P | P | P   | 0/5     |       |   |   |   |     | 5/5     |
|                                 |        | IsoVac (Red Dye)   | P    | P | P | P | P   | 0/5     | N/A   |   |   |   |     |         |
| RGA                             | ORS    |                    |      |   |   |   | 5/5 |         |       |   |   |   | 5/5 |         |

## Correlation CHLD

- GSFC and MSFC were able to fail the same devices when plugging did not occur.
- If plugging is considered, CHLD correlates with Kr85.
- When GSFC and MSFC both identified a fine leak, the leak rates correlated within  $< 1/4$  magnitude.

## Correlation OLT

- There is a lack of correlation between OLT and CHLD/Kr85 data for TO-18 packages and one gross TO-5 package.
- If OLT data was omitted, the results in this study correlate in regards to segregating failed devices and plugging.
- OLT could not test ceramic/metal lid UB parts.

## Correlation Kr85

- MSFC and IsoVac correlate 100%.
- All gross leaks and plugged devices were identified, and fine leak rates were within  $< 1/4$  magnitude.
- IsoVac initial testing and ORS IGA correlate 100% proving these devices were all leakers at one time.



## Plugging

- The **most reliable leak test** is the one performed during initial lot screening by the manufacturer.
- Leaky parts can gradually and/or completely plug at anytime.
- The mechanism of plugging requires more study to determine root cause.

## IGA

- All constituent gases should be considered in the pass/fail criteria of MIL-STD-883 TM 1018.

## OLT

- OLT should undergo additional qualification testing prior to its inclusion into the seal test methods.
- A list of devices that can not be tested with this instrument should be identified in the test methods.

### Plugging

- Resealed RGA holes and performed a bake out test on 8 gross leakers to study the one way leak phenomena. 3 devices recovered prior to bake out (1 gross/2 fine). Isolated the leak to the seal area of the gross leaker using Kr-85 “sniffing” technique. The oven experienced thermal runaway during testing which jeopardized further leak testing.

### IGA

- Submitted essential comments to add constituent gases to the pass/fail criteria of MIL-STD-883 TM 1018.

### Testing

- Supporting a second instrument correlation study of MIL-STD-883 devices.

## Gross Leak Standard Development Plan



### Phase 1: Design

- Adsorption Free Construction Materials
- Fabricated Using Typical Manufacturing Processes
- Micron Sized Holes ( ? - ?  $\mu\text{m}$ )



### Phase 2: Validation

- Round Robin Measurements with Hermetic Test Equipment
- Identification of Strengths & Weaknesses
- Design Review: Go/No Go Decision



### Phase 3: Implementation

- MIL-STD Optimization Based on Validation
- NIST and/or ANSI Standardization

## **Objective**

- Provide input to DLA Land & Maritime to optimize hermeticity specifications based on the knowledge gained during correlation study, part testing, and research efforts.

## **Status**

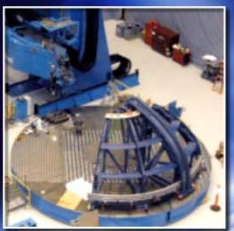
- Calculated and submitted a CHLD fixed rate table to support the tightening MIL-STD-883 leak rate limits for class K devices.
- Currently working with Minco Technologies to correlate Kr85 gross leak test data of various small volume package samples which have 5, 4, 3, 2, and 1 mil holes. The data will be used to determine if the current specification for gross leak qualification is invalid as written and evaluate smaller diameter holes to determine optimum size.
- Evaluating the Kr85 red dye gettering efficiency which is used to test small volume packages that fail the 5mil hole criteria in the test methods 5, 4, and 3 mil size sample holes will be drilled in-house for testing.





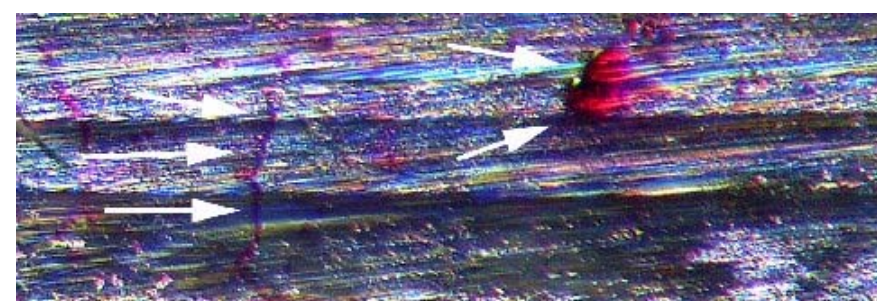
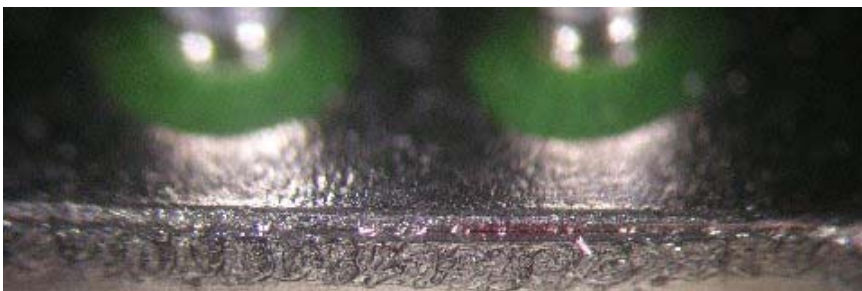
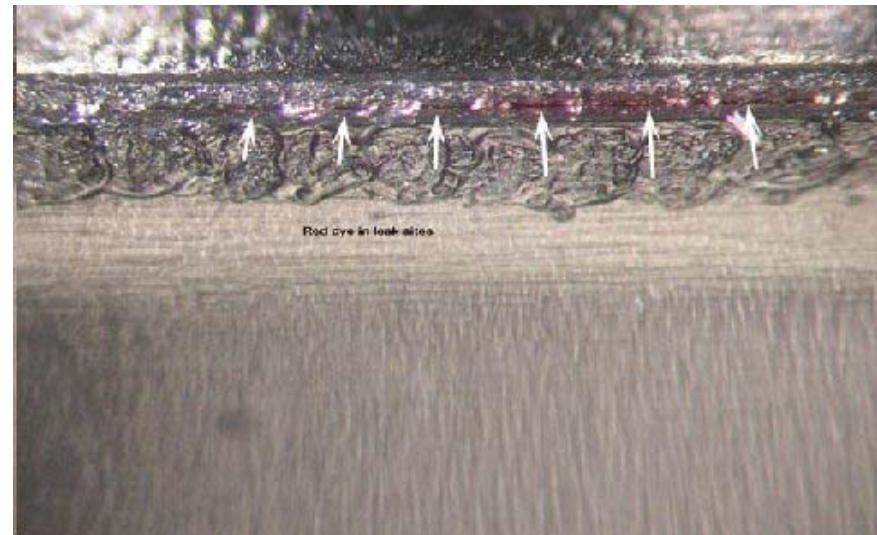
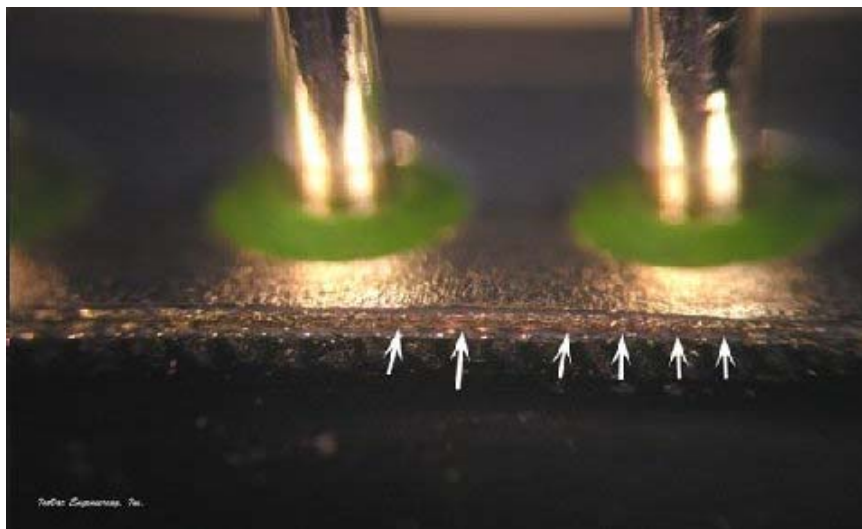
# NEPP Program Task 14-294: Joint Hermeticity Correlation Study

## Questions?



# Plugging Mechanism

These images show leaks in the weld material of TO-257 parts. The metal is "steel", which will start to rust right away in humid environments. Rust can potentially "plug holes." Gross leakers are shown below. Note that fine leaks may seal quicker.



*Courtesy of IsoVac Engineering, Inc.*



## References

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# Test Specifics: CHLD



| Group              | Desc.           | LDC   | Volume<br>(cc) | L (air)<br>(atm-cc/sec) | Item  | SN's                       | He Bombing         |              |                         | CHLD Set Values |                |          |              | Testing        |               |
|--------------------|-----------------|-------|----------------|-------------------------|-------|----------------------------|--------------------|--------------|-------------------------|-----------------|----------------|----------|--------------|----------------|---------------|
|                    |                 |       |                |                         |       |                            | Pressure<br>(psig) | Time<br>(hr) | R1 (He)<br>(atm-cc/sec) | Chamber         | Insert<br>(mm) | GLT      | Method       | Dwell<br>(min) | Test<br>Order |
| Set 1<br>(T0-18)   | 2N2907A         | 0937* | 0.0345         | 5.00E-09                | Fine  | 1-5                        | 60                 | 90           | 8.03E-09                | Small           | 7/11           | 1.00E-09 | 20/3/30/30/3 | 20/24          | SN            |
|                    |                 |       |                |                         | Gross | B07, B19, B27,<br>B37, B42 | 60                 | 90           | 8.03E-09                | Small           | 7/7            | 5.00E-10 | 10/3/10/10/3 | 40/45          | SN            |
| Set 2<br>(T0-5)    | 2N2219A         | 1009  | 0.2244         | 5.00E-09                | Fine  | 6-10                       | 60                 | 4            | 5.96E-11                | Small           | 13/7           | 1.00E-09 | 10/3/10/10/3 | 10/14          | SN            |
|                    |                 |       |                |                         | Gross | 1-5                        | 60                 | 2            | 2.98E-11                | Sm/Med          | 13/11          | 1.00E-09 | 20/3/50/50/5 | 12/14          | SN            |
| Set 3<br>(ceramic) | 4 Leaded<br>Lug |       | 0.0026         | 1.00E-09                | Fine  | 6-10                       | 60                 | 2            | 1.00E-10                | Small           | 7/7            | 1.00E-09 | 10/3/10/10/3 | 11/6           | SN            |
|                    |                 |       |                |                         | Gross | 1-5                        | 60                 | 2            | 1.00E-10                | Small           | 7/7            | 1.00E-09 | 10/3/10/10/3 | 10/9           | SN            |

# Raw Data: CHLD



|                |       | Sample # | CHLD          |                |     |               |                |     |
|----------------|-------|----------|---------------|----------------|-----|---------------|----------------|-----|
|                |       |          | GSFC          |                |     | MSFC          |                |     |
|                |       |          | atm-cc/sec He | atm-cc/sec Air | Jud | atm-cc/sec He | atm-cc/sec Air | Jud |
| Set 1<br>TO-18 | Fine  | a        | 3.96E-09      | Pass           | P   | 3.25E-09      | Pass           | P   |
|                |       | b        | 3.09E-09      | Pass           | P   | 2.50E-09      | Pass           | P   |
|                |       | c        | 2.62E-09      | Pass           | P   | Gross         | Gross          | G   |
|                |       | d        | 2.32E-09      | Pass           | P   | 1.82E-09      | Pass           | P   |
|                |       | e        | 2.53E-09      | Pass           | P   | Gross         | Gross          | G   |
|                | Gross | a        | 1.79E-09      | Pass           | P   | 2.25E-09      | Pass           | P   |
|                |       | b        | Gross         | Gross          | G   | Gross         | Gross          | G   |
|                |       | c        | 1.73E-09      | Pass           | P   | 2.12E-09      | Pass           | P   |
|                |       | d        | Gross         | Gross          | G   | 2.01E-09      | Pass           | P   |
|                |       | e        | 1.46E-09      | Pass           | P   | 1.90E-09      | Pass           | P   |
| TO-5           | Fine  | a        | 1.41E-09      | 2.46E-08       | F   | 1.42E-09      | 2.47E-08       | F   |
|                |       | b        | Gross         | Gross          | G   | Gross         | Gross          | G   |
|                |       | c        | 2.70E-09      | 3.40E-08       | F   | Gross         | Gross          | G   |
|                |       | d        | 1.49E-09      | 2.53E-08       | F   | Gross         | Gross          | G   |
|                |       | e        | 7.78E-10      | 1.83E-08       | F   | 5.82E-10      | 1.58E-08       | F   |
|                | Gross | a        | 1.59E-09      | 3.70E-08       | F   | Gross         | Gross          | G   |
|                |       | b        | 1.68E-09      | 3.80E-08       | F   | Gross         | Gross          | G   |
|                |       | c        | Gross         | Gross          | G   | Gross         | Gross          | G   |
|                |       | d        | 2.81E-10      | 1.55E-08       | F   | 1.80E-10      | 1.24E-08       | F   |
|                |       | e        | 3.03E-10      | 1.61E-08       | F   | 1.73E-10      | 1.22E-08       | F   |
| UB             | Fine  | a        | 6.63E-11      | Pass           | P   | 5.37E-11      | Pass           | P   |
|                |       | b        | 4.12E-11      | Pass           | P   | 4.99E-11      | Pass           | P   |
|                |       | c        | 5.91E-11      | Pass           | P   | 4.38E-11      | Pass           | P   |
|                |       | d        | 4.30E-11      | Pass           | P   | 4.19E-11      | Pass           | P   |
|                |       | e        | 4.36E-11      | Pass           | P   | 3.98E-11      | Pass           | P   |
|                | Gross | a        | Gross         | Gross          | G   | Gross         | Gross          | G   |
|                |       | b        | Gross         | Gross          | G   | Gross         | Gross          | G   |
|                |       | c        | Gross         | Gross          | G   | Gross         | Gross          | G   |
|                |       | d        | Gross         | Gross          | G   | Gross         | Gross          | G   |
|                |       | e        | Gross         | Gross          | G   | Gross         | Gross          | G   |



# Test Specifics: OLT



- OLT was performed by NorCom Systems Inc (located in Norristown PA) using NorCom 2020
  - NorCom 2020 resolution: 15nm
  - Pressurization gas: Helium

| Parameters   | TO-5          | TO-18*        | UB package                        |
|--|---------------|---------------|-----------------------------------|
| Package Cavity [cc]  | 0.2244        | 0.0345        | 0.0026                            |
| Test Time  | 10 hours      | 5 hours       | <i>Could not be tested in OLT</i> |
| Helium pressure +/- modulation [psi]                       | 57.3psi +/- 2 | 57.3psi +/- 2 |                                   |
| Fine Leak Limit (L <sub>2</sub> ) [atm cc/sec He]          | 1.37e-08      | 1.37e-08      |                                   |
| Test Sensitivity of NorCom 2020 for this part <sup>†</sup> | 6.0e-9        | 3.7e-09       |                                   |
| Fine Leak Limit (L) [atm cc/sec air] per MIL-STD-750       | 5e-09         | 5e-09         |                                   |
| Number of parts tested                                     | 10            | 10            |                                   |

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 (\*) TO-18 lid stiffness and package size are right at the edge of NorCom 2020 detection capability

(†) Conversion  $L = L_2 / 2.69$  results in L values that are tighter than stated in MIL-STD-750

# Raw Data: OLT



|                |       | Sample # | OLT<br>NorCom |                |       |
|----------------|-------|----------|---------------|----------------|-------|
|                |       |          | atm-cc/sec He | atm-cc/sec Air | Judge |
| Set 1<br>TO-18 | Fine  | a        | Gross         | Gross          | G     |
|                |       | b        | 3.31E-08      | 1.23E-08       | F     |
|                |       | c        | 4.97E-08      | 1.85E-08       | F     |
|                |       | d        | Pass          | Pass           | P     |
|                |       | e        | Gross         | 5.00E-06       | G     |
|                | Gross | a        | No Data       | No Data        | ND    |
|                |       | b        | Gross         | 5.00E-06       | G     |
|                |       | c        | 2.48E-07      | 9.22E-08       | F     |
|                |       | d        | 3.38E-08      | 1.26E-08       | F     |
|                |       | e        | Pass          | Pass           | P     |
| TO-5           | Fine  | a        | Pass          | Pass           | P     |
|                |       | b        | 7.85E-08      | 2.92E-08       | F     |
|                |       | c        | Pass          | Pass           | P     |
|                |       | d        | 2.24E-08      | 8.33E-09       | F     |
|                |       | e        | Pass          | Pass           | P     |
|                | Gross | a        | Pass          | Pass           | P     |
|                |       | b        | Pass          | Pass           | P     |
|                |       | c        | Gross         | Gross          | G     |
|                |       | d        | Pass          | Pass           | P     |
|                |       | e        | Pass          | Pass           | P     |
| UB             | Fine  | a        | No Data       | No Data        | ND    |
|                |       | b        | No Data       | No Data        | ND    |
|                |       | c        | No Data       | No Data        | ND    |
|                |       | d        | No Data       | No Data        | ND    |
|                |       | e        | No Data       | No Data        | ND    |
|                | Gross | a        | No Data       | No Data        | ND    |
|                |       | b        | No Data       | No Data        | ND    |
|                |       | c        | No Data       | No Data        | ND    |
|                |       | d        | No Data       | No Data        | ND    |
|                |       | e        | No Data       | No Data        | ND    |



# Test Specifics: MSFC Kr85



| Mark V<br>System Parameters   | Leak Test | Bomb Conditions   |  |    |
|---|-----------|---|--|----|
|   |           | TO-18   | T0-5   | UB |
| SA = 230 $\mu$ Ci/atm-cc<br>K = 14,444 CPM/ $\mu$ Ci<br>R = 500 CPM | Gross     | 75 psia @ 0.03 hours  |  |    |
|   | Fine      | $Q_s = 2.9 \times 10^{-9}$ atm-cc/sec Kr<br>P = 75 psia<br>T = 0.57 hrs | $Q_s = 5.8 \times 10^{-10}$ atm-cc/sec Kr<br>P = 75 psia<br>T = 2.87 hrs |    |

# Raw Data: Kr85



|                |       | Sample # | Kr 85         |                |   |                |      |               |                |           |
|----------------|-------|----------|---------------|----------------|---|----------------|------|---------------|----------------|-----------|
|                |       |          | IsoVac        |                |   | IsoVac Red Dye |      | MSFC          |                |           |
|                |       |          | atm-cc/sec Kr | atm-cc/sec Air |   |                |      | atm-cc/sec Kr | atm-cc/sec Air | Judgement |
| Set 1<br>TO-18 | Fine  | a        | PASS          | PASS           | P | PASS           | PASS | PASS          | PASS           | P         |
|                |       | b        | PASS          | PASS           | P | PASS           | PASS | PASS          | PASS           | P         |
|                |       | c        | PASS          | PASS           | P | PASS           | PASS | PASS          | PASS           | P         |
|                |       | d        | PASS          | PASS           | P | PASS           | PASS | PASS          | PASS           | P         |
|                |       | e        | PASS          | PASS           | P | PASS           | PASS | PASS          | PASS           | P         |
|                | Gross | a        | 2.00E-08      | 3.42E-08       | F |                |      | 4.46E-07      | 7.63E-07       | F         |
|                |       | b        | Gross         | Gross          | G |                |      | Gross         | Gross          | G         |
|                |       | c        | PASS          | PASS           | P | PASS           | PASS | PASS          | PASS           | P         |
|                |       | d        | 1.80E-08      | 3.08E-08       | F |                |      | PASS          | PASS           | P         |
|                |       | e        | PASS          | PASS           | P | PASS           | PASS | PASS          | PASS           | P         |
| TO-5           | Fine  | a        | PASS          | PASS           | P |                |      | PASS          | 0.00E+00       | P         |
|                |       | b        | 1.40E-08      | 2.39E-08       | F |                |      | 9.3E-09       | 1.59E-08       | F         |
|                |       | c        | 2.75E-09      | 4.70E-09       | P |                |      | 1.2E-09       | 2.05E-09       | P         |
|                |       | d        | 2.30E-08      | 3.93E-08       | F |                |      | 2.40E-08      | 4.10E-08       | F         |
|                |       | e        | PASS          | PASS           | P |                |      | PASS          | PASS           | P         |
|                | Gross | a        | 1.00E-08      | 1.71E-08       | F |                |      | 1.00E-08      | 1.71E-08       | F         |
|                |       | b        | PASS          | PASS           | P |                |      | PASS          | PASS           | P         |
|                |       | c        | Gross         | Gross          | G |                |      | Gross         | Gross          | G         |
|                |       | d        | PASS          | PASS           | P |                |      | PASS          | PASS           | P         |
|                |       | e        | PASS          | PASS           | P |                |      | PASS          | PASS           | P         |
| UB             | Fine  | a        | PASS          | PASS           | P | PASS           | PASS | PASS          | PASS           | P         |
|                |       | b        | PASS          | PASS           | P | PASS           | PASS | PASS          | PASS           | P         |
|                |       | c        | PASS          | PASS           | P | PASS           | PASS | PASS          | PASS           | P         |
|                |       | d        | PASS          | PASS           | P | PASS           | PASS | PASS          | PASS           | P         |
|                |       | e        | PASS          | PASS           | P | PASS           | PASS | PASS          | PASS           | P         |
|                | Gross | a        | Gross         | Gross          | G |                |      | Gross         | Gross          | G         |
|                |       | b        | Gross         | Gross          | G |                |      | Gross         | Gross          | G         |
|                |       | c        | Gross         | Gross          | G |                |      | Gross         | Gross          | G         |
|                |       | d        | Gross         | Gross          | G |                |      | Gross         | Gross          | G         |
|                |       | e        | Gross         | Gross          | G |                |      | Gross         | Gross          | G         |

## What are the leak rate limits?

- **MIL-STD-750F, Test Method 1071.11 “Hermetic Seal”**

- *Equivalent standard leak rates (atm cc/s air) for volumes:*

- ❑  $\leq 0.002$  cc:  $5 \times 10^{-10}$
    - ❑  $> 0.002$  and  $\leq 0.02$  cc:  $1 \times 10^{-9}$
    - ❑  $> 0.02$  and  $\leq 0.5$  cc:  $5 \times 10^{-9}$
    - ❑  $> 0.5$  cc:  $1 \times 10^{-8}$

- **MIL-STD-883J, Test Method 1014.14 “Seal”**

- *Equivalent standard leak rates (atm cc/s air) for volumes:*

- ❑  $\leq 0.05$  cc:  $5 \times 10^{-8}$  except  $1 \times 10^{-9}$  for Hybrid Classes S and K
    - ❑  $> 0.05$  and  $\leq 0.4$  cc:  $1 \times 10^{-7}$  except  $5 \times 10^{-9}$  for Hybrid Classes S and K
    - ❑  $> 0.4$  cc:  $1 \times 10^{-6}$  except  $1 \times 10^{-8}$  for Hybrid Classes S and K



## How do we determine optimum leak rate requirements?

Leak Rates : Vol cc : Time to Exchange **50%** atmosphere

| Volume   | 1.00E-06   | 5.00E-07   | 1.00E-07    | 5.00E-08   | 1.00E-08  | 5.00E-09 | 1.00E-09  | 5.00E-10   |
|----------|------------|------------|-------------|------------|-----------|----------|-----------|------------|
| 0.002 cc | 0.4 Hrs    | 0.8 Hrs    | 3.9 Hrs     | 7.7 Hrs    | 1.6 Days  | 3.2 Days | 16.0 Days | 32 Days    |
| 0.01 cc  | 1.9 Hrs    | 3.9 Hrs    | 1 Days      | 2 Days     | 8.0 Days  | 16 Days  | 80 Days   | 160.5 Days |
| 0.1 cc   | 19 Hrs     | 2 Days     | 8 Days      | 16 Days    | 80.2 Days | 160 Days | 2.2 Years | 4.4 Years  |
| 0.4 cc   | 3 Days     | 6 Days     | 32 Days     | 64 Days    | 321 Years | 2 Years  | 8.8 Years | 17.6 Years |
| 0.75 cc  | 6 Days     | 12 Days    | 60 Days     | 120.3 Days | 2 Years   | 3 Years  | 16 Years  | 33.0 Years |
| 1 cc     | 8 Days     | 16 Days    | 80 Days     | 160.5 Days | 2 Years   | 4 Years  | 22 Years  | 44 Years   |
| 3 cc     | 24 Days    | 48 Days    | 240.7 Years | 1.3 Years  | 7 Years   | 13 Years | 66 Years  | 132 Years  |
| 5 cc     | 40 Days    | 80 Days    | 1.1 Years   | 2.2 Years  | 11 Years  | 22 Years | 110 Years | 220 Years  |
| 8 cc     | 64 Days    | 128.4 Days | 1.8 Years   | 3.5 Years  | 18 Years  | 35 Years | 176 Years | 352 Years  |
| 10 cc    | 80 Days    | 160.5 Days | 2.2 Years   | 4.4 Years  | 22 Years  | 44 Years | 220 Years | 440 Years  |
| 12 cc    | 96 Days    | 192.5 Days | 2.6 Years   | 5.3 Years  | 26 Years  | 53 Years | 264 Years | 528 Years  |
| 15 cc    | 120.3 Days | 240.7 Days | 3.3 Years   | 6.6 Years  | 33 Years  | 66 Years | 330 Years | 659 Years  |

|          |           |
|----------|-----------|
| Volume   | 1.00E-10  |
| 0.002 cc | 4.4 Years |

|          |            |
|----------|------------|
| Volume   | 5.00E-11   |
| 0.002 cc | 320.9 Days |

|         |           |
|---------|-----------|
| Volume  | 1.00E-11  |
| 0.01 cc | 2.2 Years |

$$P_t = P_0 e^{-kt}$$

$$k = \frac{\text{leak rate}}{\text{vol cc}}$$

$$t = \text{time (sec)}$$

This "Exchange Table" shows the number of 'hours,' 'days,' or 'years' required for a device to ingest 50% of the atmosphere to which it is exposed, based on the volume of the part, (cc), and the leak rate of the part.

These exchange values have been studied and confirmed using Kr85 measured leak rates and IGA evaluation.

MIL-STD-883 TM 1014 Leak Rate Limits

MIL-STD-750 TM 1071 Leak Rate Limits



## How do we determine optimum leak rate requirements?

Leak Rates : Vol cc : Time to Exchange **90%** atmosphere

| Volume   | 1.00E-06  | 5.00E-07  | 1.00E-07    | 5.00E-08   | 1.00E-08    | 5.00E-09  | 1.00E-09    | 5.00E-10    |
|----------|-----------|-----------|-------------|------------|-------------|-----------|-------------|-------------|
| 0.002 cc | 1.3 Hrs   | 2.6 Hrs   | 12.8 Hrs    | 1.1 Days   | 5.3 Days    | 10.7 Days | 53.3 Days   | 107 Days    |
| 0.01 cc  | 6.4 Hrs   | 12.8 Hrs  | 3 Days      | 5 Days     | 26.7 Days   | 53 Days   | 267 Days    | 1.5 Years   |
| 0.1 cc   | 3 Days    | 5 Days    | 27 Days     | 53 Days    | 266.5 Days  | 1 Years   | 7.3 Years   | 14.6 Years  |
| 0.4 cc   | 11 Days   | 21 Days   | 107 Days    | 213 Days   | 3 Years     | 6 Years   | 29.2 Years  | 58.4 Years  |
| 0.75 cc  | 20 Days   | 40 Days   | 200 Days    | 1.1 Years  | 5 Years     | 11 Years  | 55 Years    | 109.5 Years |
| 1 cc     | 27 Days   | 53 Days   | 267 Days    | 1.5 Years  | 7 Years     | 15 Years  | 73 Years    | 146 Years   |
| 3 cc     | 80 Days   | 160 Days  | 2.2 Years   | 4.4 Years  | 22 Years    | 44 Years  | 219 Years   | 438 Years   |
| 5 cc     | 133 Days  | 267 Days  | 3.7 Years   | 7.3 Years  | 37 Years    | 73 Years  | 365 Years   | 730 Years   |
| 8 cc     | 213 Days  | 1.2 Years | 5.8 Years   | 11.7 Years | 58 Years    | 117 Years | 584 Years   | 1,168 Years |
| 10 cc    | 267 Days  | 1.5 Years | 7.3 Years   | 14.6 Years | 73 Years    | 146 Years | 730 Years   | 1,460 Years |
| 12 cc    | 320 Days  | 1.8 Years | 8.8 Years   | 17.5 Years | 88 Years    | 175 Years | 876 Years   | 1,752 Years |
| 15 cc    | 1.1 Years | 2.2 Years | 10.95 Years | 21.9 Years | 109.5 Years | 219 Years | 1,095 Years | 2,190 Years |

|         |           |
|---------|-----------|
| Volume  | 1.00E-10  |
| 0.01 cc | 7.3 Years |

|          |           |
|----------|-----------|
| Volume   | 5.00E-11  |
| 0.002 cc | 2.9 Years |

|          |            |
|----------|------------|
| Volume   | 1.00E-11   |
| 0.002 cc | 14.6 Years |

$$P_t = P_0 e^{-kt}$$

$$k = \frac{\text{leak rate}}{\text{vol cc}}$$

$$t = \text{time (sec)}$$

This "Exchange Table" shows the number of 'hours,' 'days,' or 'years' required for a device to ingest 90% of the atmosphere to which it is exposed, based on the volume of the part, (cc), and the leak rate of the part.

These exchange values have been studied and confirmed using Kr85 measured leak rates and IGA evaluation.

MIL-STD-883 TM 1014 Leak Rate Limits

MIL-STD-750 TM 1071 Leak Rate Limits

